Search Notes

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
10/603,353	HUI ET AL.	
Examiner	Art Unit	
/BINH K. TIEU/	2614	

SEARCHED					
Class	Subclass	Date	Examiner		
455	101, 343	9-12-09	BICT.		
	403				
	572, 574				
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370	252, 342				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
WEST DATABASES SEARCH	9/11/2007	ВКТ
WEST DATABASES SEARCHES	9/12/2007	вкт